NEMS Mass Sensor by Focused Ion Beam Fabrication

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ABSTRACT

The possibility of using paddle-type resonators for mass/chemical sensor applications is explored. An analytical model of a magneto-motive-driven paddle resonator is derived to determine intrinsic behaviour, response and sensitivity to mass adsorption. Confirmation of the model was carried out using the ABAQUS FEA package. Preliminary devices have been manufactured using focused ion beam fabrication techniques.

Keywords: FIB fabrication, mass sensor, nano-resonator

1 INTRODUCTION

At present, chemical detection technologies are principally based on adaptation of laboratory techniques. A number of spectroscopic methods that utilise optical absorption, light scattering, luminescence, atomic fluorescence or refractive index changes have been explored [1]. However, these methods are still based on laboratory analysis on extracted samples. Hence they do not provide real-time data and are generally complicated, time-consuming and expensive.

Recently, there has been a rising demand for real-time in situ chemical detection technologies, as monitoring of specific substances is vital in many industrial and research fields, ranging from clinical analysis, environmental control to industrial processes. The demands also extend to safety and military services, especially for hazardous materials, contraband and explosive chemicals.

Interest in sensors and actuators and the rapid growth of nanotechnology have led to a new horizon for the development of sensor devices. The availability of new fabrication technologies is promoting the growth of micro- and nano-electromechanical systems (MEMS and NEMS), oscillators and resonant systems.

Many researchers have shown that microcantilevers (MC) in dynamic mode are a major candidate for such a task [2, 3], providing exceptionally high sensitivity to additional mass [4].

This paper explores another type of resonator, namely a paddle resonator, which operates in dynamic mode through torsional vibration of its shafts. It offers better response to changes in additional mass with structures of similar size to MC. Focused Ion Beam (FIB) is the selected manufacturing technique. It is an extremely versatile fabrication tool which has the capabilities for milling, deposition and inspection in nanometer-scale.

2 DESIGN PRINCIPLES

2.1 Structural Design

Essentially, a paddle resonator is a double-clamped beam with large plate at the mid-point. It is designed to resonate at fundamental frequency in torsion through the beams. The plate is to be coated by chemically selective polymer compounds for detection. The schematic drawing of the structure is shown in Fig 1. This structure exhibits many possible advantages over MC, such as;

- Larger area of detection with similar sized structure
- Linear response to mass addition
- Less intrinsic bending in the beams due to the weight of the detecting plate
- No stress induced effect, upon detection, as beams do not have chemical layer coating
- Utilise bending moment to drive, therefore less power required for significant movement

From Fig. 1, \( l_p \) and \( w_p \) are length and width of the plate, \( l_s \) and \( w_s \) are length and width of the shaft and \( t \) is thickness of membrane.

The movement in the beams can be described by the torque-deflection equation:

\[
T = GJ \frac{\partial \theta}{\partial x}
\]
Where $T$ is torque, $G$ is shear modulus, $\theta$ is angle of twist and $x$ is distance along the beam. $J_t$ is the “Torsional Parameter” of a non-circular bar which is defined below [5].

$$J_t = ab \left[ \frac{16}{3} - 3.36 \frac{b}{a} \left( 1 - \frac{b^4}{12a^4} \right) \right]$$

(2)

(for rectangular cross-sectional beam of $a \geq b$)

By considering a uniform shaft segment of length $l_s$, with overall angular deformation $\theta$, the torsional stiffness, $K_t$, may be written as:

$$K_t = \frac{T}{\theta} = \frac{G J_t}{l_s}$$

(3)

The mass of the plate $m_p$ generates rotational resistance or “Polar Mass Moment Of Inertia” $J_p$, given by:

$$J_p = \frac{m_p}{12} \left( w_p^2 + r^2 \right)$$

(4)

During vibration, it is assumed that the plate is a rigid structure rotating about the weightless shafts. The natural frequency $f_n$ of the device is defined by:

$$f_n = \frac{1}{2\pi} \sqrt{\frac{2K_t}{J_p}}$$

(5)

2.2 Driving Force

The structure is to be driven at its natural frequency by the Lorentz force. The proposed layout of the drive-system is shown in Fig. 2. The tracks are to be FIB-deposited Platinum (Pt). The top track carries an AC current in the presence of perpendicular external magnetic field producing up-/downwards oscillating forces.

$$F = B l I$$

(7)

By rearranging the Equation (7) and assuming a $Q$ factor, the angle of twist (maximum amplitude) can be written, in terms of all factors, as:

$$\theta = \frac{Q B l I}{2 G J_t}$$

(8)

2.3 Pick-Up System

Monitoring change in natural frequency can be done through exploitation of electromagnetic induction.

The Faraday-Lenz law of Electromagnetic Induction states that:

$$\varepsilon = -\frac{d\Phi_b}{dt}$$

(9)

Where $\varepsilon$ is induced emf and $\Phi_b$ is magnetic flux through a finite area. During resonance, the non-current-carrying bottom track in Fig. 2.2 cut magnetic field line perpendicularly, generating an emf of:

$$\varepsilon = -B l_P r \frac{d\theta}{dt}$$

(10)
By assuming the excitation to be simple harmonic with \( \theta = \theta_{\text{max}} \sin pt \) and \( p = 2\pi f \). Equation (10) can be rewritten
to get the final form of \( \varepsilon \):

\[
\varepsilon = -B l r \theta_{\text{max}} p \cos pt
\]

(11)

The induced emf is to be monitored through a
controlled feedback loop, which will readjust the driving
frequency automatically upon the detection of a shift in
natural frequency. Thus the shift can be recorded then
converted to additional mass through calculation.

3 FABRICATION

The resonant device is made from 200 nm-thick Si\(_3\)N\(_4\)
membrane window supplied by Silson Ltd. All fabrication
is done using the FEI Strata\textsuperscript{TM} DB 235. The process has 4
steps involving both Pt deposition and Si\(_3\)N\(_4\) millings.

The SEM images of the device, Fig. 3, show a FIB-
fabricated paddle resonator. The Pt tracks are the smallest
feature, roughly 75 nm in width and 75 nm in height. The
process also exhibits good reproducibility and multiple-
device-manufacturing capability.

A smaller resonator, fabricated from 100 nm-thick
Si\(_3\)N\(_4\) membrane window to further show the capability of
the FIB, is shown in Fig. 4, with a plate dimension of
1000 nm x 1000 nm and 400 nm-long beams.

4 ANALYSIS AND RESULTS

By analytically modelling the theoretical behaviour of
the device with the dimensions (as in Fig. 2), the natural
frequency of the Si\(_3\)N\(_4\) paddle (i.e. without the Pt tracks) is
predicted to be approximately 10.6 MHz. The ABAQUS
Finite Element Analysis package confirms that the device
will be in torsional vibration at fundamental frequency of
12.5 MHz. This indicates a reasonable correlation between
the analytical model and the FEA methods. The difference
of 2 MHz is believed to be explained by stress in the
structure upon rotation in the shafts, which the FEA
package took into account. With the addition of Pt tracks,
the analytical model predicts that the natural frequency
would drop down to about 8.8 MHz, compared to the FEA
prediction of 11.5 MHz.

Hence, the analytical model is believed to be sufficient
enough to preliminarily indicate more complex behaviours
of the device i.e. with proposed drive and pick up systems.

The model prediction of the device’s response to mass
adsorption is shown in Fig. 5. Sensitivity is approximately
300 Hz per femtogram. This is based on the assumptions
of \( B \) of 1 T, input \( I \) of 100 \( \mu \)A and \( Q \) of 10000. This
produce roughly 10° angle of twist which results an
induced emf of roughly 70 \( \mu \)V peak-to-peak.
By applying the same analytical model to the device in Fig. 4, the smaller paddle resonator would have natural frequency of 79.9 MHz, with mass sensitivity of 133 Hz per attogram.

Fig. 4. Submicron FIB fabricated paddle with Pt track

**Shift in Natural Frequency - Adsorption Mass**

![Graph showing shift in natural frequency vs. adsorption mass](image)

Fig. 5. Plots of frequency shift upon mass adsorption showing a linear response of the resonator to mass addition

**CONCLUSION**

Analysis of a simple paddle resonator using analytical and FEA modeling show acceptable agreement. The device, driven to resonance by Lorentz forces and with manageable electromagnetic induction readout, shows high sensitivity to mass adsorption with linear response. FIB milling and deposition have been used successfully to fabricate initial experimental devices in Si3N4 membranes, with good integrity and reproducibility. The capability of FIB for fabrication of submicron (NEMS) prototype has been demonstrated.

**REFERENCES**